## Notice of References Cited Application/Control No. 10/519,693 Examiner VAN T. PHAM Applicant(s)/Patent Under Reexamination KOBAYASHI ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0147321	08-2003	Okubo et al.	369/47.53
*	В	US-6,765,850	07-2004	Shiozawa et al.	369/47.52
*	С	US-5,828,636	10-1998	Matsumoto et al.	369/44.27
	D	US-			
	E	US-			
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## FOREIGN PATENT DOCUMENTS

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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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